


<b>Form PTO-1449 Modified</b>  <b>List of Patents and Publications Cited by Applicant</b> (Use several sheets if necessary)  <b>U.S. Department of Commerce Patent and Trademark Office</b>		<b>Docket No.</b> RSW9-2001-0006-US1		<b>Application No. N/A</b>		
		<b>Applicant(s) M. Etgen, J. Bailey, E. Zegarra, D. Li</b>				
		<b>Filing Date</b> Herewith		<b>Group</b> N/A		
<b>U.S. PATENT DOCUMENTS</b>						
Examiner Initials		Document No.	Date	Name	Class	Subclass
<i>ME</i>	AA	5,483,468	01/09/1996	Chen et al	364	551.01
<i>ME</i>	AB	5,566,291	10/15/1996	Boulton et al	395	161
<i>ME</i>	AC	5,877,763	03/02/1999	Berry et al	345	345
<i>ME</i>	AD	5,903,881	05/11/1999	Schrader et al	704	42
<i>ME</i>	AE	6,029,176	02/22/2000	Cannon	707	104
<i>ME</i>	AF	6,125,375	09/26/2000	Atkins et al	707	502
	AG					
	AH					
	AI					
	AJ					
<b>FOREIGN PATENT DOCUMENTS</b>						
Examiner Initials		Document No.	Date	Country	Translation Yes No	
<i>ME</i>	AL	WO 00/1935	06/04/2000	PCT		
	AM					
	AN					
	AO					
	AP					
	AQ					
	AR					
<b>Examiner</b> <i>[Signature]</i>			<b>Date Considered</b> 10.22/03			

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		<b>Applicant(s)</b> M. Etgen, J. Bailey, E. Zegarra, D. Li	
		<b>Filing Date</b> Herewith	<b>Group</b> N/A
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>			
	AA	Stephen G. Eick, Joseph L. Steffen and Eric E. Sumner, Jr., "Seesoft-A Tool For Visualizing Line Oriented Software Statistics", IEEE Transactions on Software Engineering, Vol. 18, #11 (pp.957-968) (1992)	
	AB		
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	AK		
	AL		
<b>Examiner</b>		<b>Date Considered</b> 10/27/03	